

# POWER MOS FET

# D82BN2,M2

0.6 AMPERES 200, 150 VOLTS RDS(ON) = 1.5 Ω

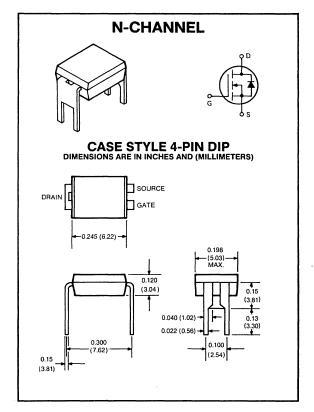
FIELD EFFECT POWER TRANSISTOR

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

#### **Features**

- Polysilicon gate Improved stability and reliability
- No secondary breakdown Excellent ruggedness
- Ultra-fast switching Independent of temperature
- Voltage controlled High transconductance
- Low input capacitance Reduced drive requirement
- Excellent thermal stability Ease of paralleling



#### maximum ratings (T<sub>A</sub> = 25°C) (unless otherwise specified)

RATING	SYMBOL	IRFD210/D82BN2	IRFD211/D82BM2	UNITS	
Drain-Source Voltage	V <sub>DSS</sub>	200	150	Volts	
Drain-Gate Voltage, $R_{GS}$ = 1M $\Omega$	V <sub>DGR</sub>	200	150	Volts	
Continuous Drain Current @ $T_A = 25^{\circ}C^{(1)}$ @ $T_A = 100^{\circ}C^{(1)}$	, ID	0.6 0.35	0.6 0.35	A A	
Pulsed Drain Current <sup>(2)</sup>	I <sub>DM</sub>	2.5	2.5	Α	
Gate-Source Voltage	V <sub>GS</sub>	±20	±20	Volts	
Total Power Dissipation @ T <sub>A</sub> = 25°C Derate Above 25°C	P <sub>D</sub>	1.0 8	1.0 8	Watts mW/°C	
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	-55 to 150	°C	

#### thermal characteristics

Thermal Resistance, Junction to Ambient <sup>(1)</sup>	$R_{ heta JA}$	125	125	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	TL	300	300	°C

<sup>(1)</sup> Device mounted to vertical pc board in free air with drain lead soldered to 0.20 in<sup>2</sup> minimum copper run area.

(2) Repetitive Rating: Pulse width limited by max. junction temperature.

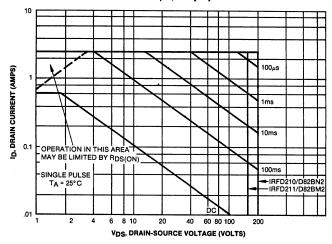
### electrical characteristics (T<sub>A</sub> = 25°C) (unless otherwise specified)

CHARACTERISTIC		SYMBOL	MIN	TYP	MAX	UNIT
off characteristics						
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0V, I <sub>D</sub> = 250 μA)	IRFD210/D82BN2 IRFD211/D82BM2	BVDSS	200 150	_		Volts
Zero Gate Voltage Drain Current (V <sub>DS</sub> = Max Rating, V <sub>GS</sub> = 0V, T <sub>A</sub> = 25°C) (V <sub>DS</sub> = Max Rating, × 0.8, V <sub>GS</sub> = 0V, T <sub>A</sub> = 125°C)		I <sub>DSS</sub>	_		250 1000	μΑ
Gate-Source Leakage Current (V <sub>GS</sub> = ±20V)		IGSS			±500	nA
on characteristics*				,		
Gate Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$ )	T <sub>A</sub> = 25°C	V <sub>GS(TH)</sub>	2.0		4.0	Volts
On-State Drain Current (V <sub>GS</sub> = 10V, V <sub>DS</sub> = 10V)		I <sub>D(ON)</sub>	0.6			Α
Static Drain-Source On-State Resistance (V <sub>GS</sub> = 10V, I <sub>D</sub> = 0.3A)		R <sub>DS(ON)</sub>	_	1.1	1.5	Ohms
Forward Transconductance (V <sub>DS</sub> = 10V, I <sub>D</sub> = 0.3A)		9fs	0.35	0.4	-	mhos
dynamic characteristic	<b>S</b> .					
Input Capacitance	V <sub>GS</sub> = 0V	C <sub>iss</sub>	_	120	150	pF
Output Capacitance	V <sub>DS</sub> = 25V	Coss		40	80	pF
Reverse Transfer Capacitance	f = 1 MHz	C <sub>rss</sub>		10	25	pF
switching characteristi	CS*					
Turn-on Delay Time	V <sub>DS</sub> = 90V	t <sub>d(on)</sub>	_	5	_	ns
Rise Time	I <sub>D</sub> = 0.3A, V <sub>GS</sub> = 15V	t <sub>r</sub>	_	15	_	ns
Turn-off Delay Time	$R_{GEN}$ = 50 $\Omega$ , $R_{GS}$ = 12.5 $\Omega$	t <sub>d(off)</sub>		10	_	ns
Fall Time	(R <sub>GS (EQUIV.)</sub> = 10Ω)	t <sub>f</sub>		10	_	ns

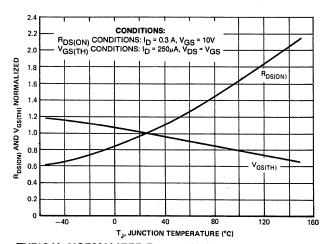
## source-drain diode ratings and characteristics\*

Continuous Source Current	Is	-		0.60	Α
Pulsed Source Current	I <sub>SM</sub>		_	2.5	Α
Diode Forward Voltage $I_S = 0.60A$ $(T_A = 25^{\circ}C, V_{GS} = 0V)$	V <sub>SD</sub>	_	0.8	2.0	Volts
Reverse Recovery Time (I <sub>S</sub> = 0.6A, di <sub>s</sub> /dt = 100A/ $\mu$ s, T <sub>A</sub> = 125°C)	t <sub>rr</sub> Q <sub>RR</sub>	_	100 0.75	_	ns μC

<sup>\*</sup>Pulse Test: Pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%



**MAXIMUM SAFE OPERATING AREA** 



TYPICAL NORMALIZED  $\mathbf{R}_{\text{DS(ON)}}$  and  $\mathbf{V}_{\text{GS(TH)}}$  vs. temp.